

# FDS4070N7 40V N-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

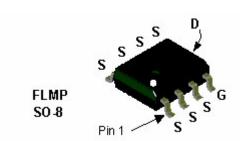
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

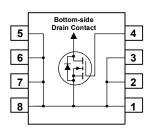
### Applications

- Synchronous rectifier
- DC/DC converter

### Features

- 15.3 A, 40 V.  $R_{DS(ON)}$  = 7 m $\Omega$  @ V<sub>GS</sub> = 10 V
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability
- Fast switching, low gate charge
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		40	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
ID	Drain Current – Continuous	(Note 1a)	15.3	A
	– Pulsed		60	
PD	Maximum Power Dissipation	(Note 1a)	3.0	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

# **Thermal Characteristics**

R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	40	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.5	

# Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS4070N7	FDS4070N7	13"	12mm	2500 units

Parameter	Test Conditions	Min	Тур	Max	Units
ource Avalanche Ratings (Note	2)	•			
Drain-Source Avalanche Energy	Single Pulse, $V_{DD}$ =40V, $I_D$ =15.3A			310	mJ
Drain-Source Avalanche Current				15.3	А
acteristics					
	$V_{GS} = 0 V$ . $I_D = 250 \mu A$	40			V
Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C		42		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = 32 V$ , $V_{GS} = 0 V$			1	μA
Gate-Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
Gate-Body Leakage, Reverse	V <sub>GS</sub> = -20 V, V <sub>DS</sub> = 0 V			-100	nA
acteristics (Note 2)	·				
	$V_{DS} = V_{CS}$ , $I_D = 250 \mu A$	2	3.9	5	V
Gate Threshold Voltage	$I_D = 250 \ \mu\text{A}$ , Referenced to 25 °C		-8	-	mV/°C
	$V_{cc} = 10 V$ $I_c = 15.3 A$		5	7	mΩ
On–Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 15.3\text{ A}, \text{ T}_{J} = 125^{\circ}\text{C}$		7.5	, 11	1115.2
Forward Transconductance	$V_{DS} = 10 V$ , $I_{D} = 15.3 A$		52		S
Characteristics					
Input Capacitance	$V_{DS} = 20 V$ , $V_{GS} = 0 V$ ,		2819		pF
Output Capacitance	f = 1.0 MHz		600		pF
Reverse Transfer Capacitance			291		pF
G Charactoristics (Note 2)		1	1 1		
	$V_{DD} = 20 V$ , $I_D = 1 A$ .	İ	16	29	ns
•	$V_{GS} = 10$ V, $R_{GEN} = 6 \Omega$				ns
	-				ns
,	-				ns
	$V_{DS} = 20 V$ , $I_D = 15.3 A$ ,		-	-	nC
Gate-Source Charge	V <sub>GS</sub> = 10 V		15		nC
Gate-Drain Charge	-1		14		nC
	Drain-Source Avalanche Ratings (Note Drain-Source Avalanche Energy Drain-Source Avalanche Current <b>acteristics</b> Drain–Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate–Body Leakage, Forward Gate–Body Leakage, Reverse <b>acteristics</b> (Note 2) Gate Threshold Voltage Gate Threshold Voltage Temperature Coefficient Static Drain–Source On–Resistance Forward Transconductance <b>Characteristics</b> Input Capacitance Qutput Capacitance Reverse Transfer Capacitance <b>g Characteristics</b> (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Fall Time Total Gate Charge	Durce Avalanche Ratings (Note 2)Drain-Source Avalanche EnergySingle Pulse, $V_{DD}$ =40V, $I_D$ =15.3ADrain-Source Avalanche CurrentacteristicsDrain-Source Breakdown Voltage $V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ ABreakdown Voltage Temperature Coefficient $I_D$ = 250 $\mu$ A, Referenced to 25°CZero Gate Voltage Drain Current $V_{DS}$ = 32 V, $V_{GS}$ = 0 VGate-Body Leakage, Forward $V_{GS}$ = 20 V, $V_{DS}$ = 0 VGate-Body Leakage, Reverse $V_{GS}$ = -20 V, $V_{DS}$ = 0 VGate Threshold Voltage $I_D$ = 250 $\mu$ A, Referenced to 25 °CTemperature Coefficient $I_D$ = 250 $\mu$ A, Referenced to 25 °CGate Threshold Voltage $I_D$ = 250 $\mu$ A, Referenced to 25 °CTemperature Coefficient $I_D$ = 250 $\mu$ A, Referenced to 25 °CStatic Drain-Source $V_{GS}$ = 10 V, $I_D$ = 15.3 AOn-Resistance $V_{GS}$ = 10 V, $I_D$ = 15.3 ACharacteristics $V_{DS}$ = 20 V, $V_{GS}$ = 0 V,Input Capacitance $V_{DS}$ = 20 V, $V_{GS}$ = 0 V,f Characteristics(Note 2)Turn-On Delay Time $V_{DD}$ = 20 V, $I_D$ = 1A,Turn-On Rise Time $V_{GS}$ = 10 V, $I_D$ = 1A,Turn-Off Fall Time $V_{GS}$ = 20 V, $I_D$ = 15.3 A,Total Gate Charge $V_{DS}$ = 20 V, $I_D$ = 15.3 A,Vace = 10 V $V_{SS}$ = 10 V	Durce Avalanche Ratings (Note 2)Drain-Source Avalanche EnergySingle Pulse, $V_{DD}$ =40V, $I_D$ =15.3ADrain-Source Avalanche CurrentImage: Colspan="2">Comparison of the colspan="2">Single Pulse, $V_{DD}$ =40V, $I_D$ =15.3ADrain-Source Avalanche CurrentImage: Colspan="2">Image: Colspan="2">Comparison of the colspan="2">Single Pulse, $V_{DD}$ =40V, $I_D$ =15.3ADrain-Source Avalanche CurrentImage: Colspan="2">Image: Colspan="2">Comparison of the colspan="2">Comparison of th	Durce Avalanche Ratings (Note 2)Drain-Source Avalanche EnergySingle Pulse, $V_{DD}=40V$ , $I_D=15.3A$ Drain-Source Avalanche CurrentImage: Colspan="2">Image: Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2">Colspan="2"Cols	Durce Avalanche Ratings (Note 2)Drain-Source Avalanche EnergySingle Pulse, $V_{DD}$ =40V, $I_D$ =15.3A310Drain-Source Avalanche Current15.3acteristicsDrain-Source Breakdown Voltage $V_{GS} = 0$ V, $I_D = 250 \ \mu$ A40Breakdown Voltage Temperature $I_D = 250 \ \mu$ A, Referenced to 25°C42Coefficient $I_D = 250 \ \mu$ A, Referenced to 25°C42Zero Gate Voltage Drain Current $V_{DS} = 32$ V, $V_{GS} = 0$ V1Gate-Body Leakage, Forward $V_{GS} = 20$ V, $V_{DS} = 0$ V100Gate-Body Leakage, Reverse $V_{GS} = -20$ V, $V_{DS} = 0$ V-100acteristics (Note 2)Gate Threshold Voltage $I_D = 250 \ \mu$ A, Referenced to 25 °C-8Gate Threshold Voltage $I_D = 250 \ \mu$ A, Referenced to 25 °C-8Temperature Coefficient $I_D = 250 \ \mu$ A, Referenced to 25 °C-8Static Drain-Source $V_{GS} = 10$ V, $I_D = 15.3$ A5On-Resistance $V_{GS} = 10$ V, $I_D = 15.3$ A52CharacteristicsInput Capacitance $V_{DS} = 20$ V, $V_{GS} = 0$ V,2819Input Capacitance $V_{DS} = 20$ V, $V_{GS} = 0$ V,2819Output Capacitance $V_{DD} = 20$ V, $I_D = 1.4$ ,16Reverse Transfer Capacitance29112Turn-On Delay Time $V_{GS} = 10$ V, $R_{GEN} = 6$ 12Turn-On Fise Time $V_{DS} = 20$ V, $I_D = 15.3$ A,16Turn-Off Fall Time $V_{DS} = 20$ V, $I_D = 15.3$ A,47Gota Gate Charge $V_{DS} = 20$ V, $I_D = 15.3$ A,47 </td

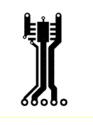
	cal Characteristics	T <sub>A</sub> = 25°C unless otherwise noted	1			
Symbol	Parameter	Test Conditions		Тур	Мах	Units
Drain-S	ource Diode Characteristics a	Ind Maximum Ratings				
ls	Maximum Continuous Drain–Source Diode Forward Current				2.5	А
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 2.5 A$ (Note 2)		0.7	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 15.3 A,		32		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	d <sub>iF</sub> /d <sub>t</sub> = 100 A/μs		39		nC

#### Notes:

1. R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.

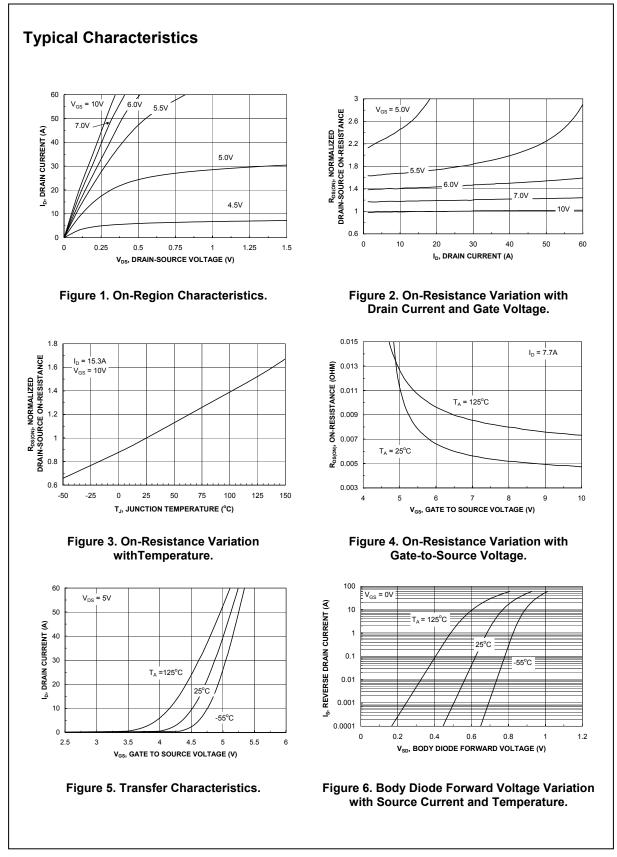


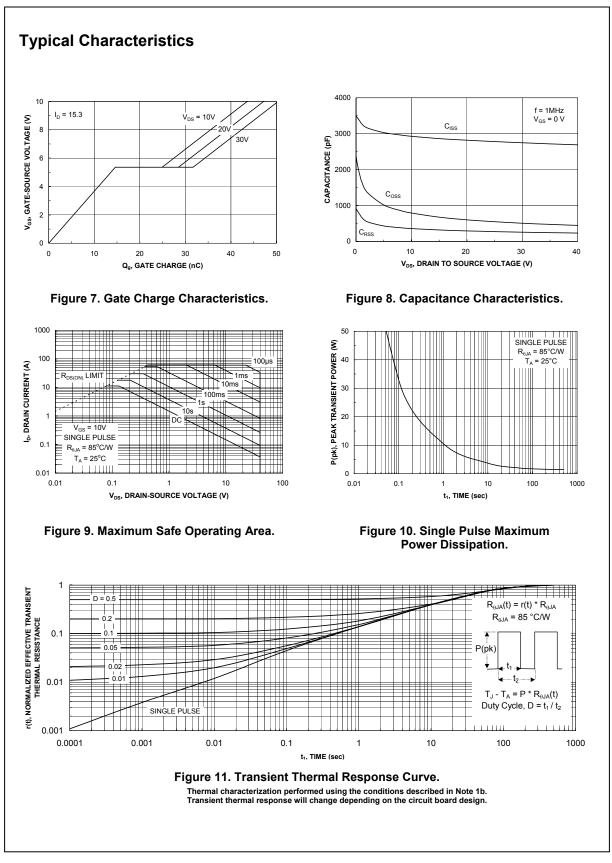
a) 40°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper



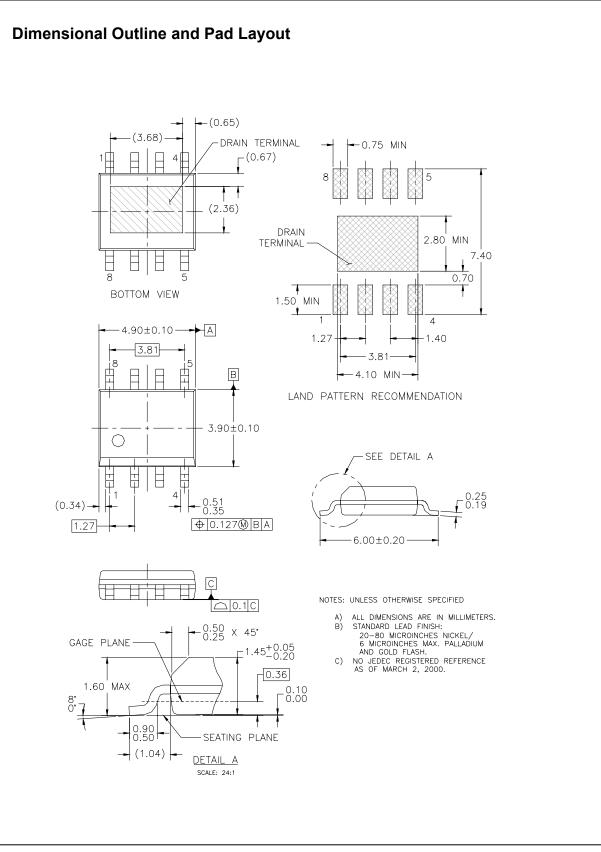
b) 85°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size pape 2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0





FDS4070N7 Rev B2 (W)



FDS4070N7 Rev B2 (W)

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